

# ZXMN3F31DN8

## 30V SO8 dual N-channel enhancement mode MOSFET

### Summary

$V_{(BR)DSS}$	$R_{DS(on)}$ ( $\Omega$ )	$I_D$ (A)
30	0.024 @ $V_{GS} = 10V$	7.3
	0.039 @ $V_{GS} = 4.5V$	5.7



### Description

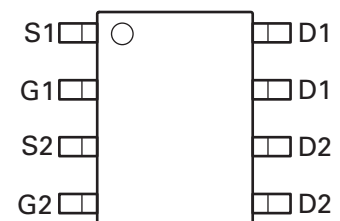
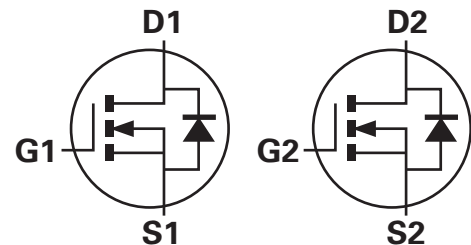
This new generation Trench MOSFET from Zetex features low on-resistance achievable with 4.5V gate drive.

### Features

- Low on-resistance
- 4.5V gate drive capability

### Applications

- DC-DC Converters
- Power management functions
- Load switching
- Motor control
- Back lighting



### Ordering information

DEVICE	Reel size (inches)	Tape width (mm)	Quantity per reel
ZXMN3F31DN8TA	7	12	500

### Device marking

ZXMN

3F31D

# ZXMN3F31DN8

## Absolute maximum ratings

Parameter	Symbol	Limit	Unit
Drain source voltage	$V_{DSS}$	30	V
Gate source voltage	$V_{GS}$	$\pm 20$	V
Continuous Drain Current @ $V_{GS}=10$ ; $T_A=25^\circ\text{C}^{(b)}$ @ $V_{GS}=10$ ; $T_A=70^\circ\text{C}^{(b)}$ @ $V_{GS}=10$ ; $T_A=25^\circ\text{C}^{(a)}$	$I_D$	7.3 5.9 5.7	A A A
Pulsed drain current <sup>(c)</sup>	$I_{DM}$	33	A
Continuous source current (body diode) <sup>(b)</sup>	$I_S$	3.5	A
Pulsed source current (body diode) <sup>(c)</sup>	$I_{SM}$	33	A
Power dissipation at $T_A=25^\circ\text{C}^{(a)(d)}$ Linear derating factor	$P_D$	1.25 10	W mW/°C
Power dissipation at $T_A=25^\circ\text{C}^{(a)(e)}$ Linear derating factor	$P_D$	1.8 14	W mW/°C
Power dissipation at $T_A=25^\circ\text{C}^{(b)(d)}$ Linear derating factor	$P_D$	2.1 17	W mW/°C
Operating and storage temperature range	$T_j, T_{stg}$	-55 to 150	°C

## Thermal resistance

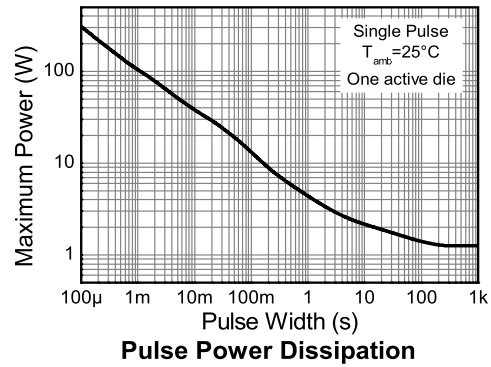
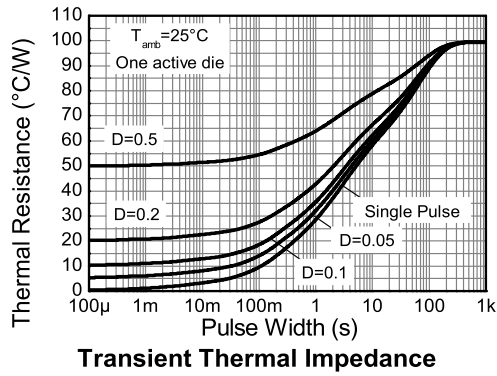
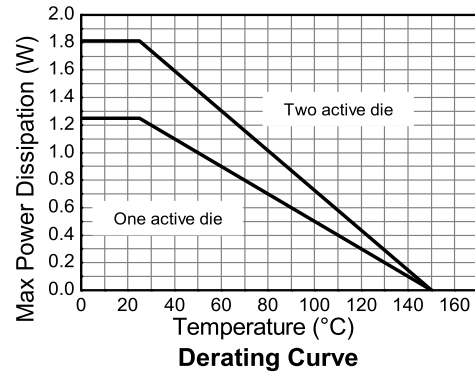
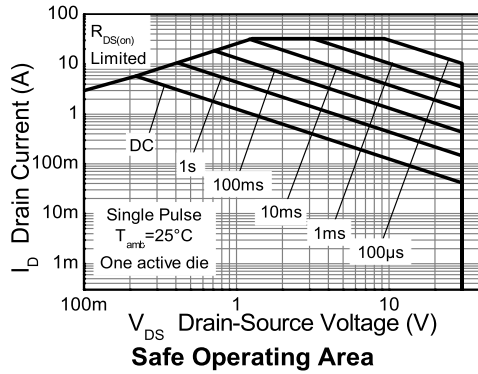
Parameter	Symbol	Limit	Unit
Junction to ambient <sup>(a)(d)</sup>	$R_{\theta JA}$	100	°C/W
Junction to ambient <sup>(a)(e)</sup>	$R_{\theta JA}$	70	°C/W
Junction to ambient <sup>(b)(d)</sup>	$R_{\theta JA}$	60	°C/W
Junction to lead <sup>(f)</sup>	$R_{\theta JL}$	53	°C/W

### NOTES:

- (a) For a device surface mounted on 25mm x 25mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.
- (b) For a device surface mounted on FR4 PCB measured at  $t \leq 10$  sec.
- (c) Repetitive rating - 25mm x 25mm FR4 PCB,  $D=0.02$ , pulse width 300 $\mu\text{s}$  - pulse width limited by maximum junction temperature.
- (d) For a dual device with one active die.
- (e) For a device with two active die running at equal power.
- (f) Thermal resistance from junction to solder-point (at end of drain lead).

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## Thermal characteristics



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## Electrical characteristics (at $T_{amb} = 25^{\circ}\text{C}$ unless otherwise stated)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Conditions
Static						
Drain-Source breakdown voltage	V <sub>(BR)DSS</sub>	30			V	I <sub>D</sub> = 250μA, V <sub>GS</sub> =0V
Zero Gate voltage drain current	I <sub>DSS</sub>			0.5	μA	V <sub>DS</sub> = 30V, V <sub>GS</sub> =0V
Gate-Body leakage	I <sub>GSS</sub>			100	nA	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V
Gate-Source threshold voltage	V <sub>GS(th)</sub>	1.0		3.0	V	I <sub>D</sub> = 250μA, V <sub>DS</sub> =V <sub>GS</sub>
Static Drain-Source on-state resistance (*)	R <sub>DS(on)</sub>			0.024 0.039	Ω Ω	V <sub>GS</sub> = 10V, I <sub>D</sub> = 7.0A V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 6.0A
Forward transconductance <sup>(*)</sup> (†)	g <sub>fs</sub>		16.5		S	V <sub>DS</sub> = 15V, I <sub>D</sub> = 7A
Dynamic (†)						
Input capacitance	C <sub>iss</sub>		608		pF	V <sub>DS</sub> = 15V, V <sub>GS</sub> =0V f=1MHz
Output capacitance	C <sub>oss</sub>		132		pF	
Reverse transfer capacitance	C <sub>rss</sub>		71		pF	
Switching (‡)(†)						
Turn-on-delay time	t <sub>d(on)</sub>		2.9		ns	V <sub>DD</sub> = 15V, I <sub>D</sub> = 1A R <sub>G</sub> ≅ 6.0Ω, V <sub>GS</sub> =10V
Rise time	t <sub>r</sub>		3.3		ns	
Turn-off delay time	t <sub>d(off)</sub>		16		ns	
Fall time	t <sub>f</sub>		8		ns	
Total gate charge	Q <sub>g</sub>		12.9		nC	V <sub>DS</sub> = 15V, V <sub>GS</sub> = 10V I <sub>D</sub> = 7A
Gate-source charge	Q <sub>gs</sub>		2.5		nC	
Gate drain charge	Q <sub>gd</sub>		2.52		nC	
Source-drain diode						
Diode Forward Voltage <sup>(*)</sup>	V <sub>SD</sub>		0.82	1.2	V	T <sub>J</sub> =25°C, I <sub>S</sub> = 1.7A, V <sub>GS</sub> =0V
Reverse recovery time <sup>(†)</sup>	t <sub>rr</sub>		12		ns	T <sub>J</sub> =25°C, I <sub>S</sub> =2.2A di/dt=100A/μs
Reverse recovery charge <sup>(†)</sup>	Q <sub>rr</sub>		4.8		nC	

### NOTES:

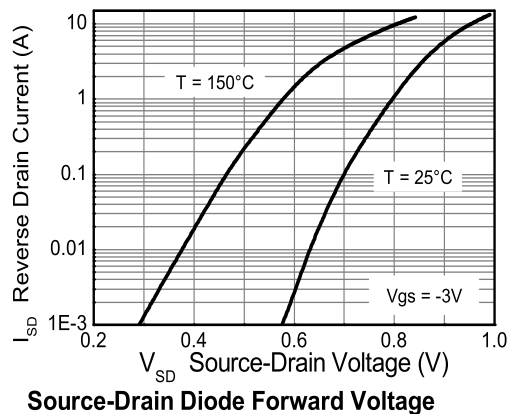
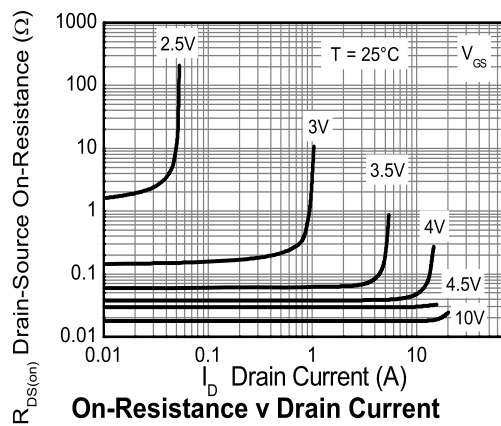
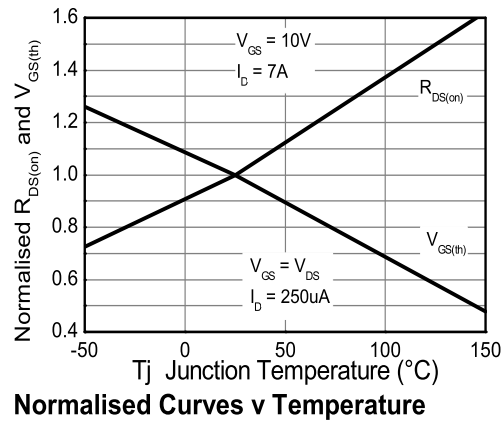
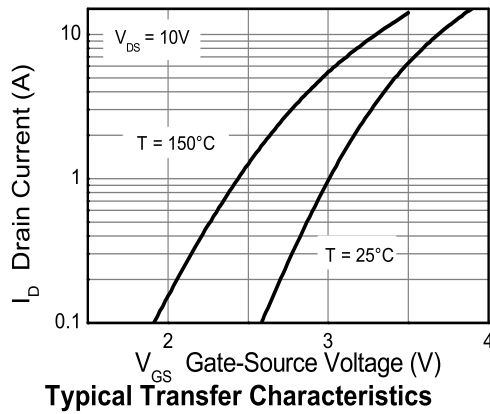
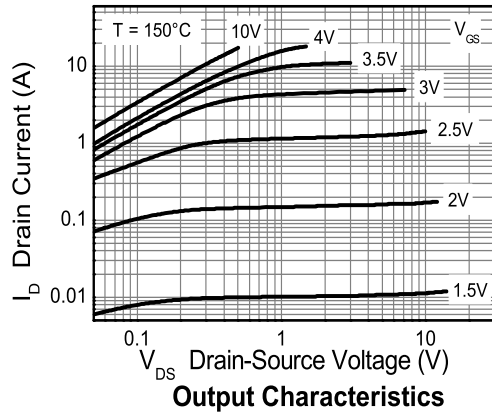
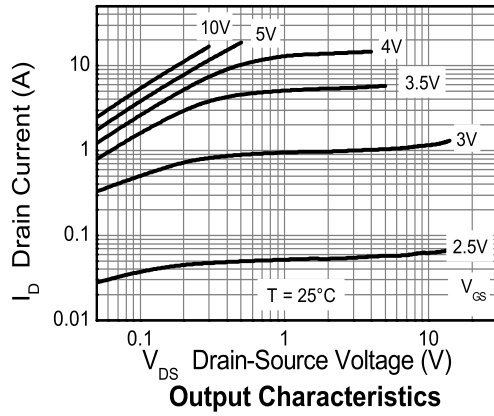
(\*) Measured under pulsed conditions. Pulse width  $\leq 300\mu\text{s}$ ; duty cycle  $\leq 2\%$ .

(†) For design aid only, not subject to production testing

(‡) Switching characteristics are independent of operating junction temperature.

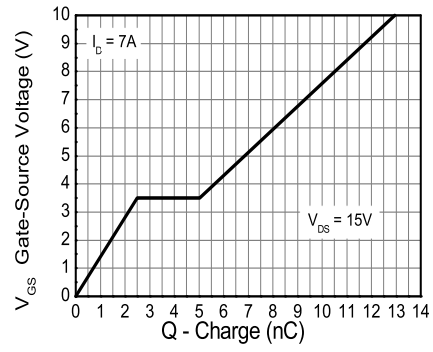
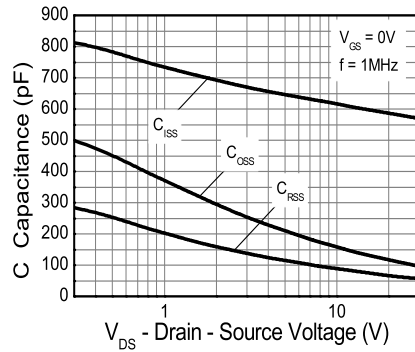
# ZXMN3F31DN8

## Typical characteristics

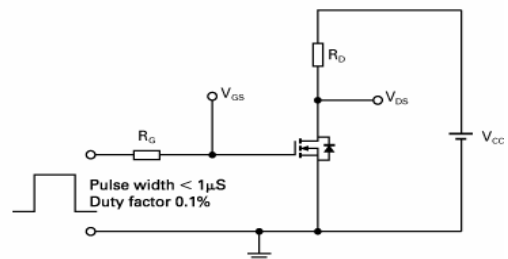
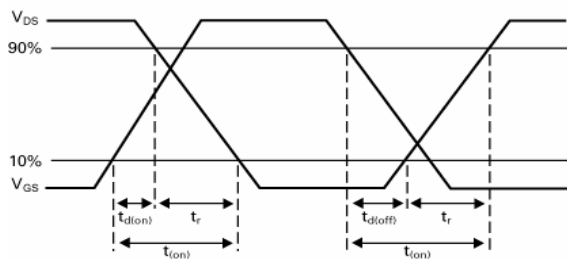
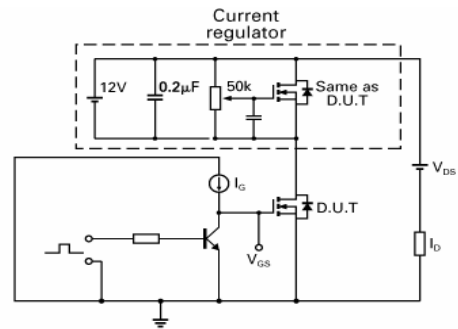
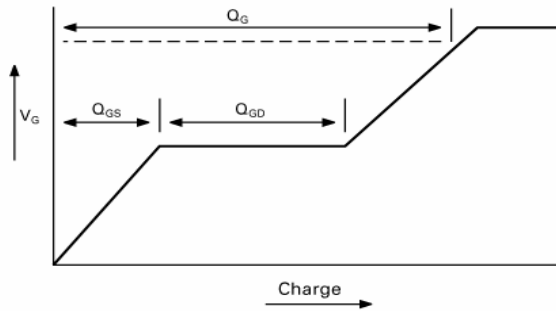


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## Typical characteristics

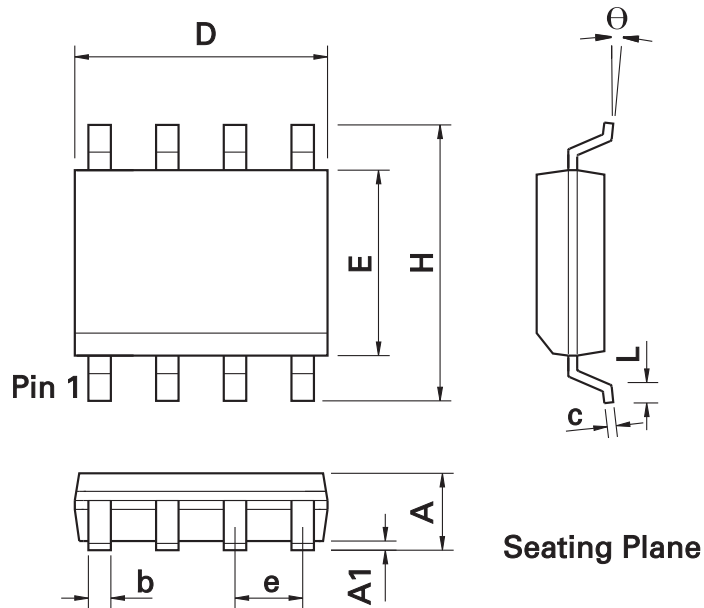


## Test circuits



# ZXMN3F31DN8

## Package outline - SO8



DIM	Inches		Millimeters		DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.053	0.069	1.35	1.75	e	0.050 BSC		1.27 BSC	
A1	0.004	0.010	0.10	0.25	b	0.013	0.020	0.33	0.51
D	0.189	0.197	4.80	5.00	c	0.008	0.010	0.19	0.25
H	0.228	0.244	5.80	6.20	$\theta$	0°	8°	0°	8°
E	0.150	0.157	3.80	4.00	h	0.010	0.020	0.25	0.50
L	0.016	0.050	0.40	1.27	-	-	-	-	-

**Note:** Controlling dimensions are in inches. Approximate dimensions are provided in millimeters

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